



Standards Developments for Fault Current Limiters

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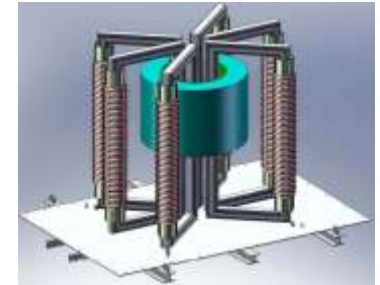
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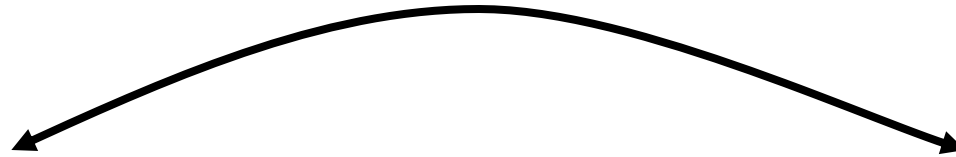
- CIGRE WG A3.23
 - “Application and Feasibility of Fault Current Limiters in Power Systems”
 - Since 2008
- IEEE PC37.302
 - “Guide for Fault Current Limiter Testing”
 - Since 2010 (2009)
- CIGRE WG D1.38
 - “Emerging Test Techniques Common to High Temperature Superconducting (HTS) Power Applications”
 - Since 2011





Why FCLs?

Compromise in Power Systems



Normal Operation:

High short-circuit capacity
(low short-circuit impedance)

- Low voltage drop (high power quality)
- High steady-state and transient stability
- Low system perturbations

Fault Condition:

Low short-circuit capacity
(high short-circuit impedance)

- Low thermal and mechanical strain
- Reduced breaker capacity

Optimal Solution:

FCL

- Low impedance during normal operation
- Fast and effective current limitation
- Automatic and fast recovery



CIGRE WG A3.23

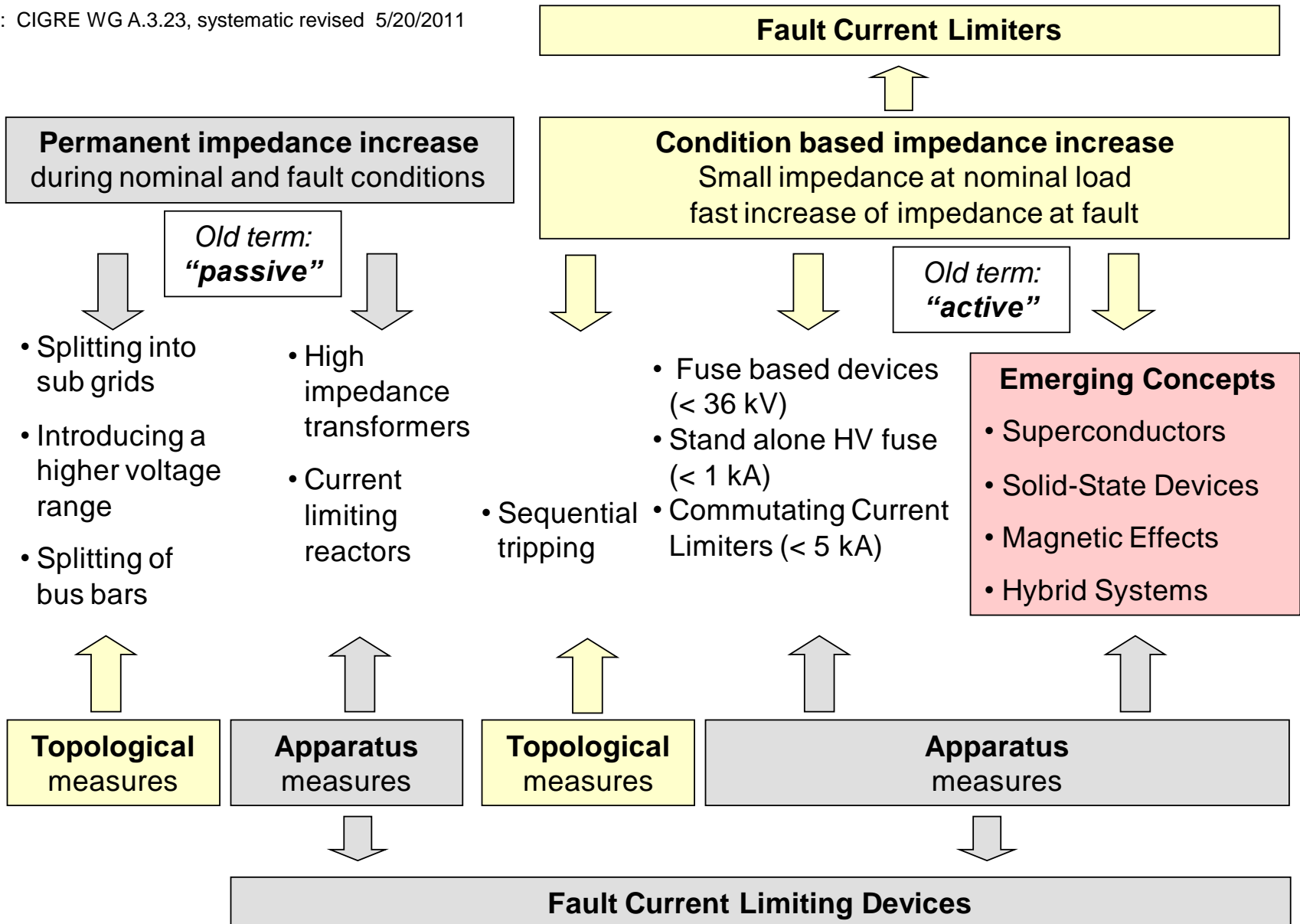


- Definition of Terms
- Fault Current Management with Fault Current Limiters
- Past Experiences and State-of-the-Art
- Fault Current Limiter Application Issues
 - Needs and requirements, specifications, selection criteria
 - Testing, meeting of requirements
 - Impact and Interactions
 - Risk Review
 - Reliability & Availability



Measures To Limit Short-Circuit Currents

Source: CIGRE WG A.3.23, systematic revised 5/20/2011





Different FCL Technologies



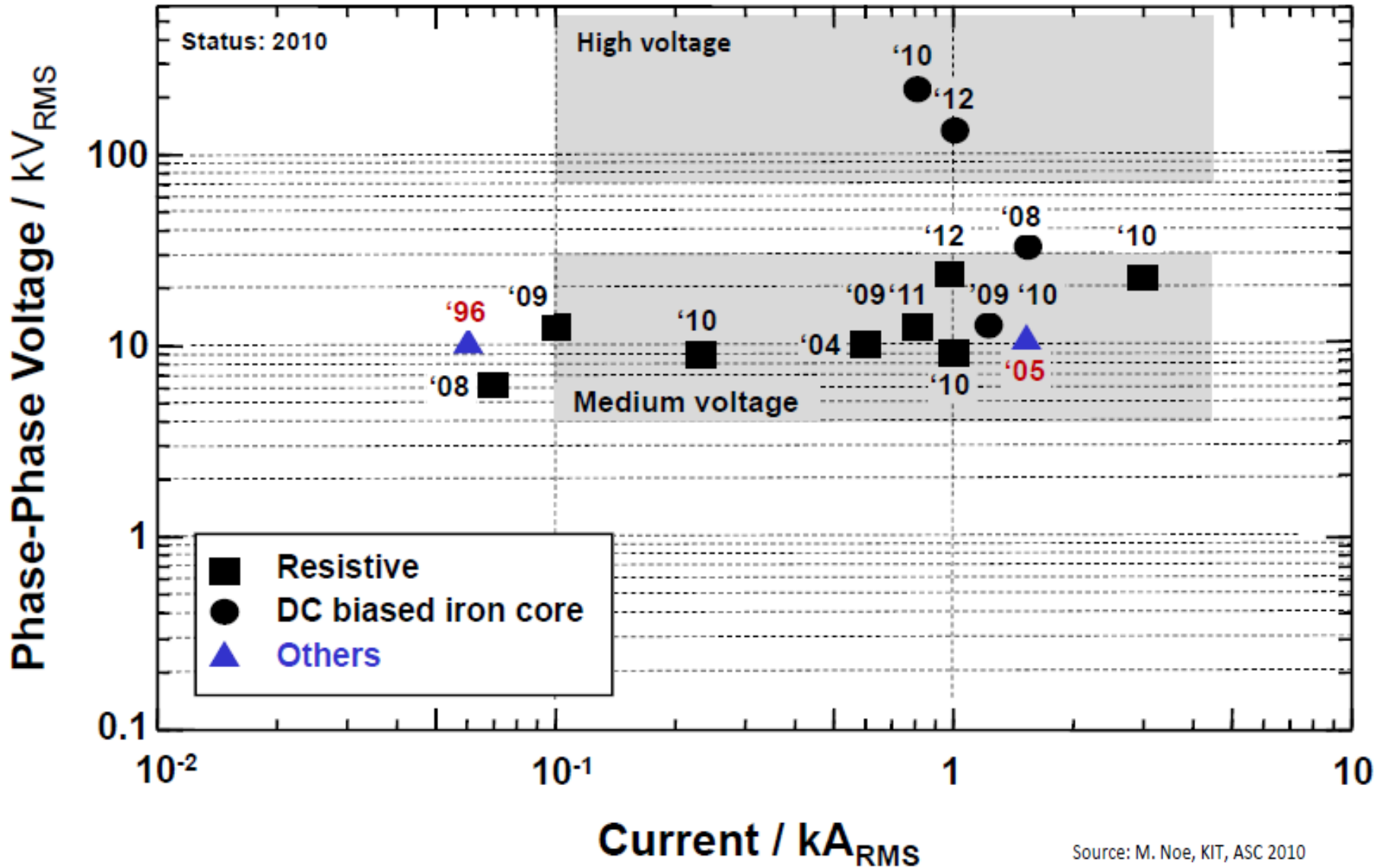
- Superconducting type
 - Resistive type (may behave resistive-inductive!)
 - Saturated (DC biased) iron core
 - Shielded iron core
 - Flux lock type
- Solid-state (semiconductor type)
 - Diode-bridge type
 - Thyristor based FCL and fault current controller
 - GTO, IGCT, ETO, IGBT, SGTO based FCL and fault current controller
 - Series line compensation with FCL feature
- Others
 - Polymer PTC resistance (positive temp. coeff.)
 - Liquid metal switch
 - High arc voltage switch
 - Hybrid switching topologie





FCL R&D Trends

SCFCL Field Tests – planned and carried out



Source: M. Noe, KIT, ASC 2010



CIGRE WG A3.23



- Feasibility and Economic Issues
 - Technical and economic benefits of fault current limiter applications
 - Selected case studies
 - Environmental benefits and acceptance issues of FCL applications
- Modeling Aspects
 - FCL modeling approaches
 - Effect of non-linear characteristic of resistive type SCFCL on simulation
 - Example case study by PSS/E and EMTDC
- Conclusions
- Reference List



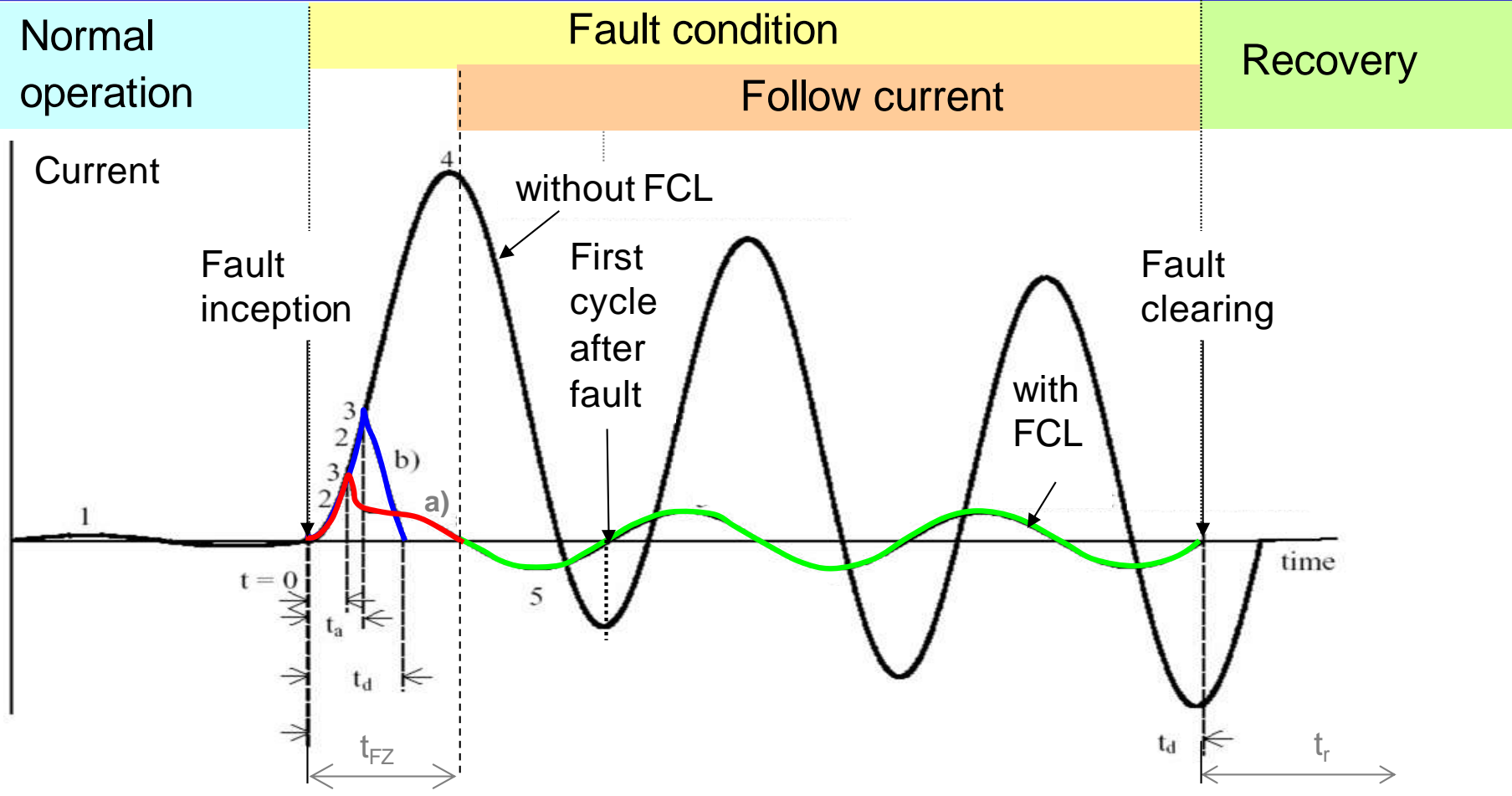
IEEE WG PC37.302



- Definitions
 - **Fault current limiter:** a device, which offers condition-based increase in resistive and/or reactive impedance between normal conducting mode and current limiting mode to limit the prospective peak and RMS fault current in an alternating current power system to the desired value.
- FCL Technology - State of The Art
- Specifications
 - Electrical Performance
 - Physical and Operational Parameters
 - Environmental
 - Safety
 - Lifespan



Representative Waveform - CIGRE



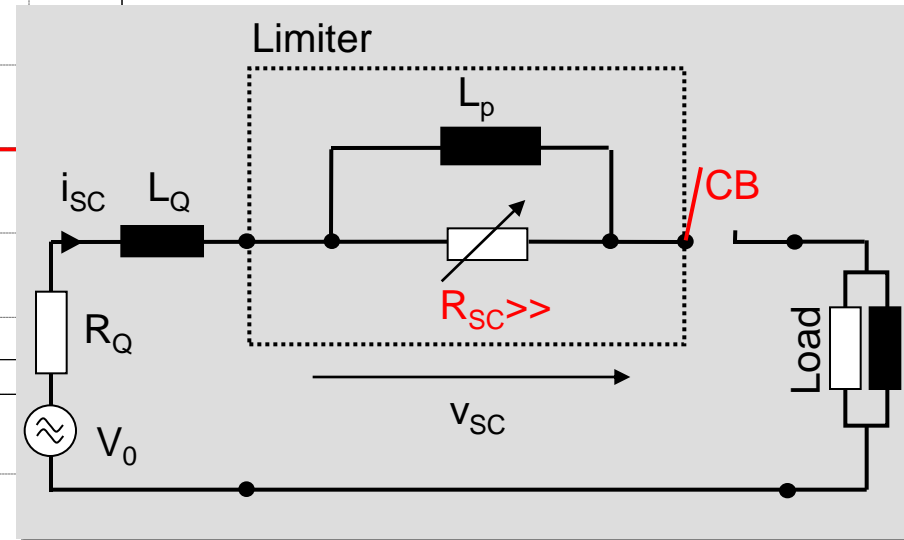
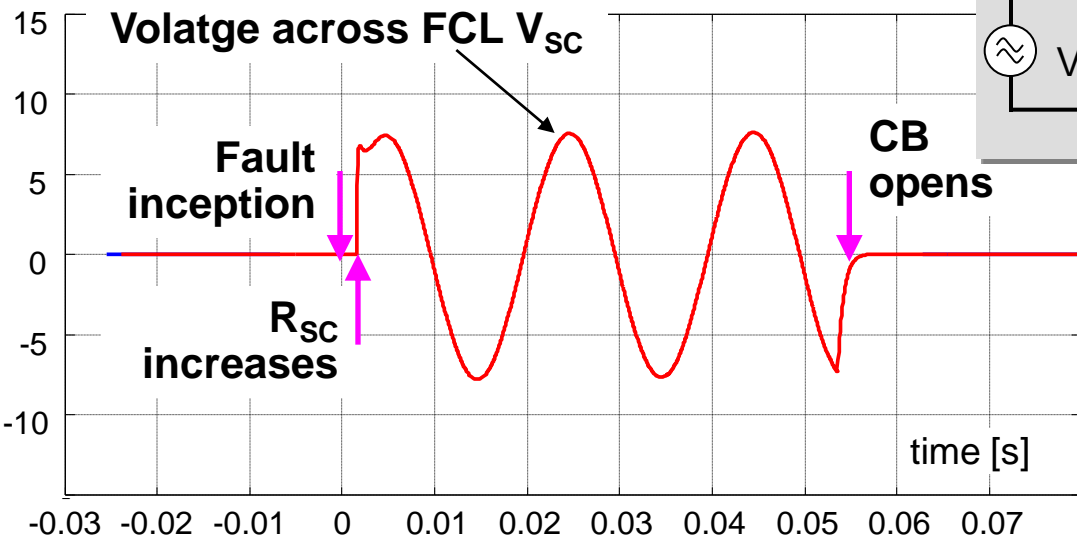
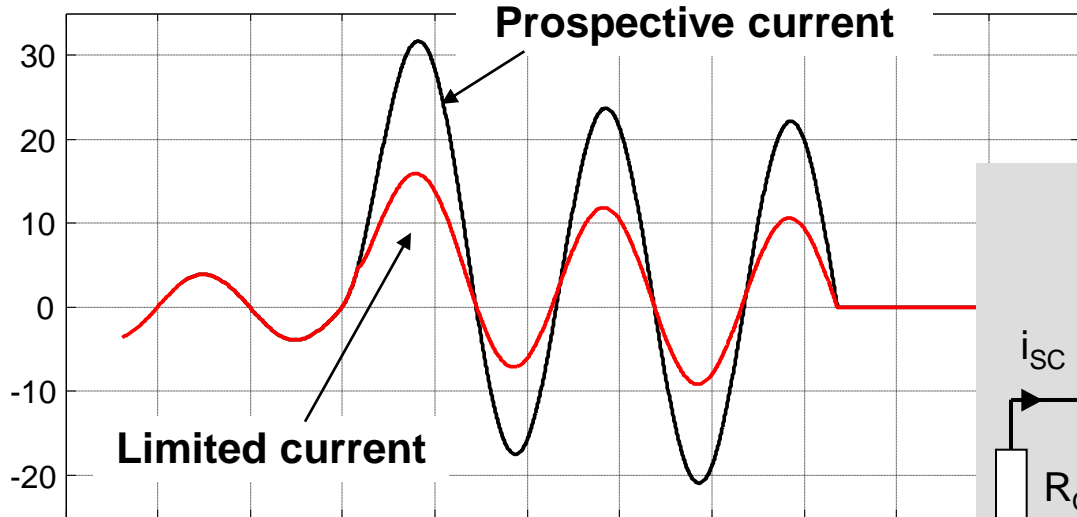
t_a action time (from $t = 0$ until 3)
 t_d fault duration time (from $t = 0$ and fault clearing)
 t_{FZ} first zero crossing time

1: load current (I_n)
2: minimum initiating current
3: first peak value of limited current
4: prospective (peak) short circuit current
5: first peak value of the follow current

t_r recovery time (between current interruption and return of the FCL to its low impedance state)



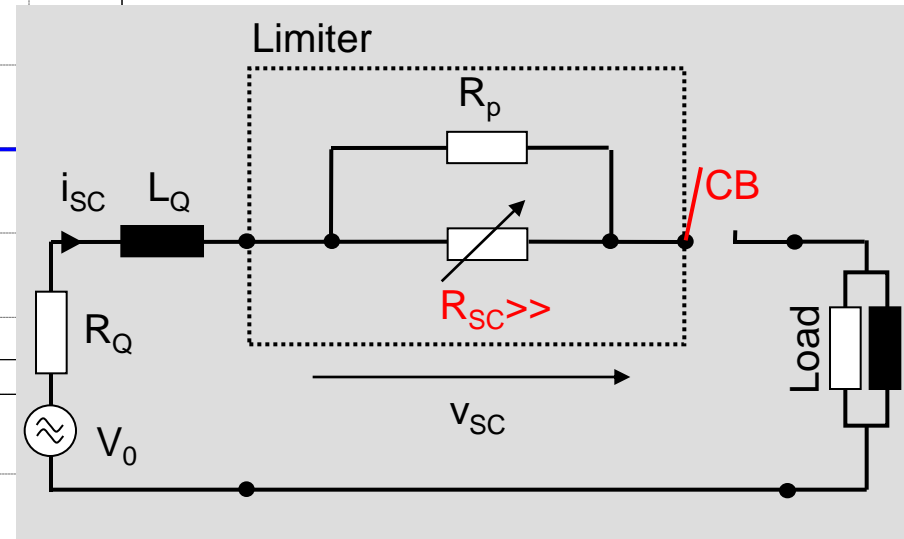
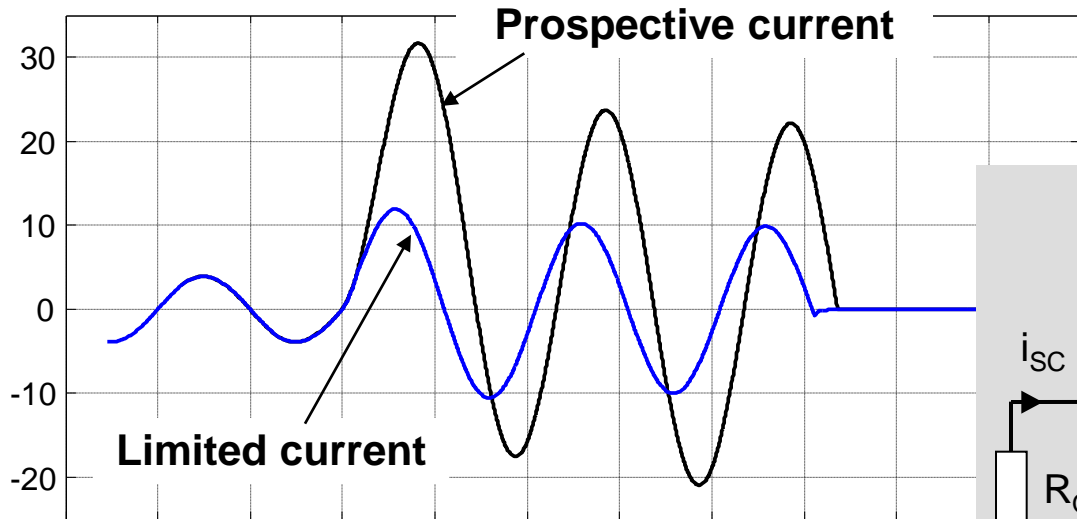
Basic FCL Principle



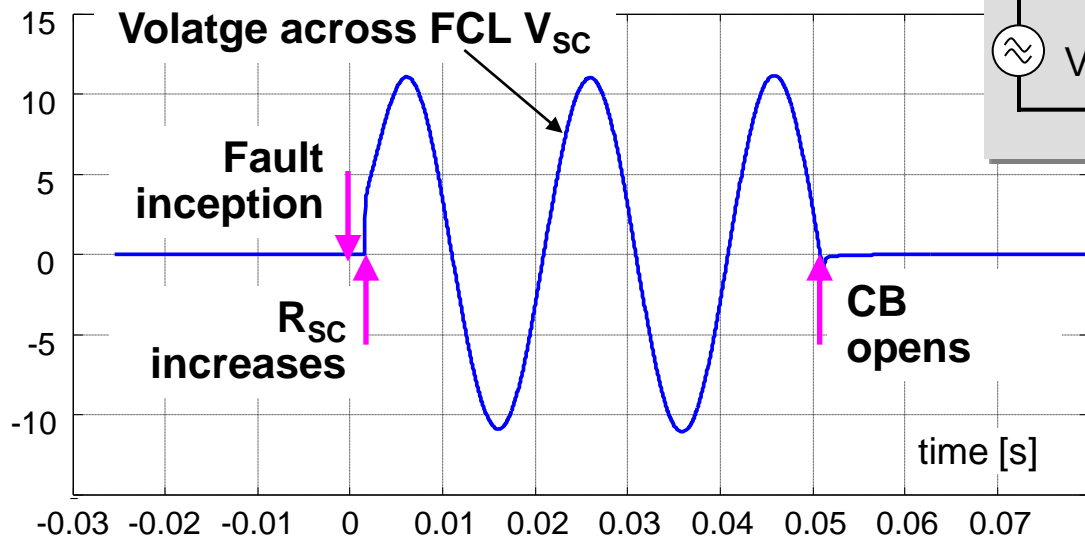
Resistive type SCFCL with **inductive** shunt



Basic FCL Principle

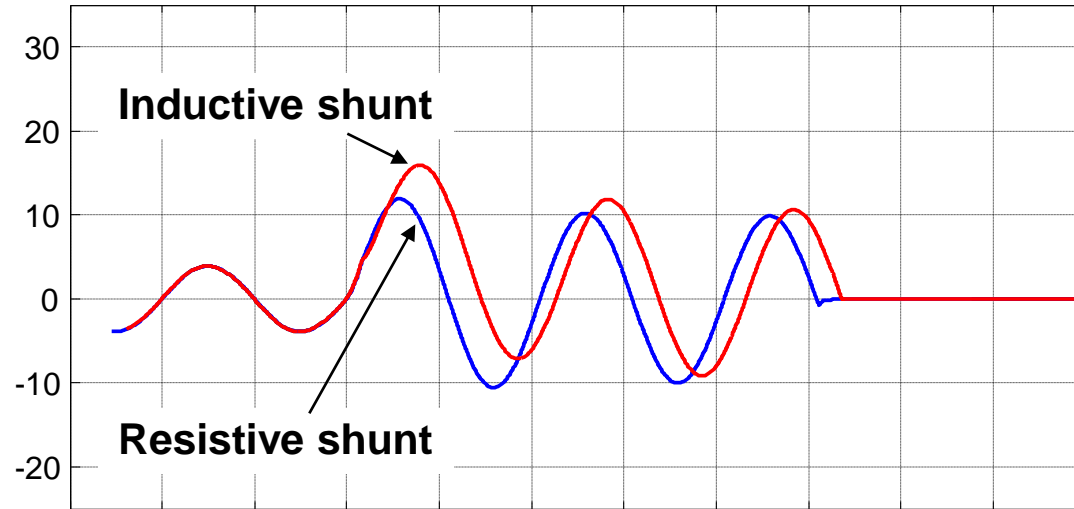


Resistive type SCFCL with **resistive** shunt





Resistive Versus Reactive Shunt

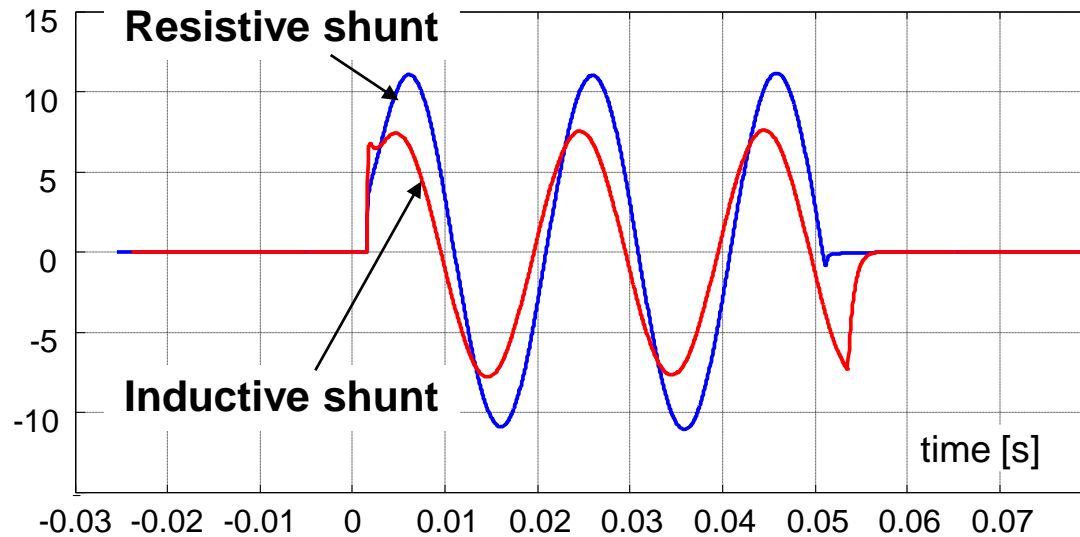


System parameters

$$I_P/I_N = 10$$

$$I_{LIM}/I_P = 0.5 \text{ (steady state)}$$

$$X/R = 10$$





Representative Waveforms for Developing Parameterization

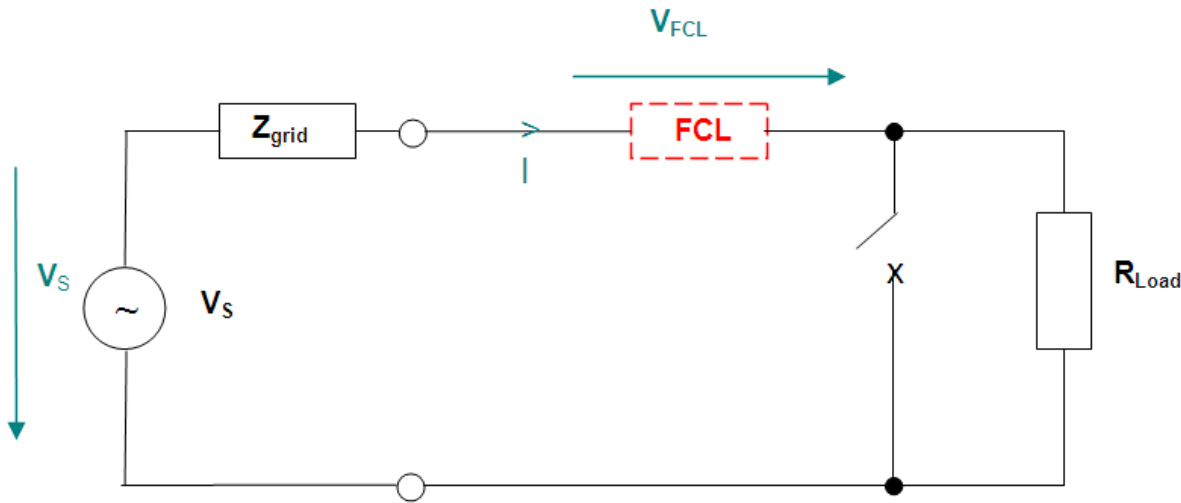


Figure 1: circuit example

- Two current & two voltage traces
- Time sequence
 - Fault inception at a source voltage zero crossing
 - 2 cycles pre-fault
 - 6 cycles fault
 - 6 cycles pos-tfault
 - Recovery under load:
 - if so, then show the recovery behavior
 - if not, indicate recovery time

$$|Z_S| = \sqrt{R_S^2 + X_S^2} = 0,05 \quad (1)$$

$$\frac{X_S}{R_S} = 20 \quad (2)$$

$$R_L = \sqrt{\left(\frac{V_S}{I_L}\right)^2 - X_S^2} - R_S \quad (3)$$

$$f = 60 \text{ Hz}$$

$$V_S = 1 \text{ pu}$$

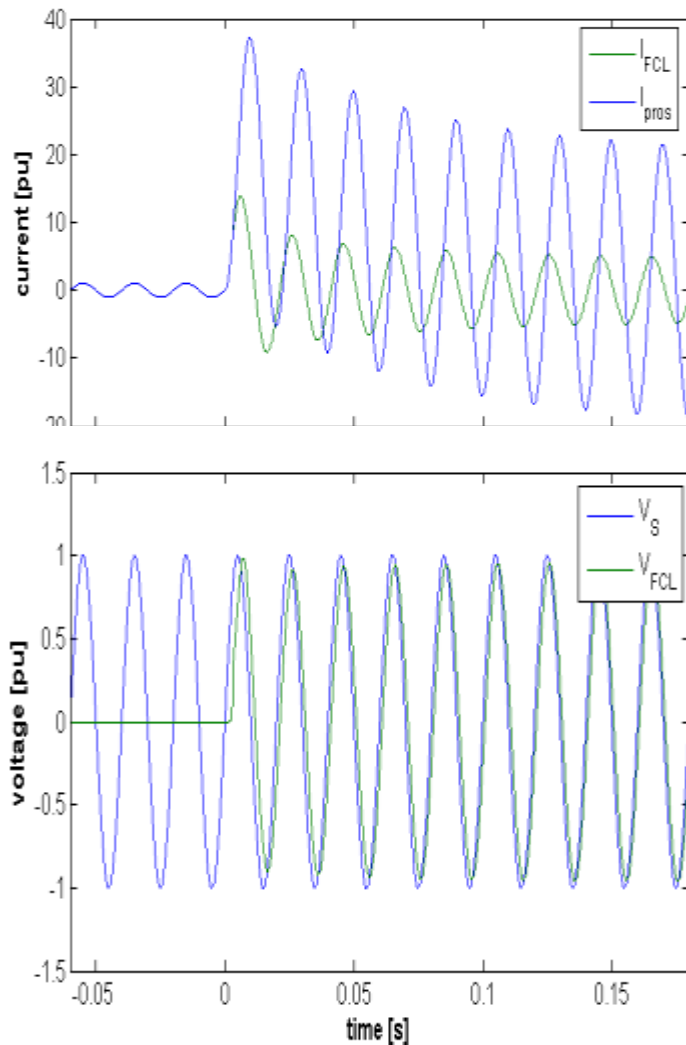
$$I_L = 1 \text{ pu}$$

$$R_S = 0.0025 \text{ pu}$$

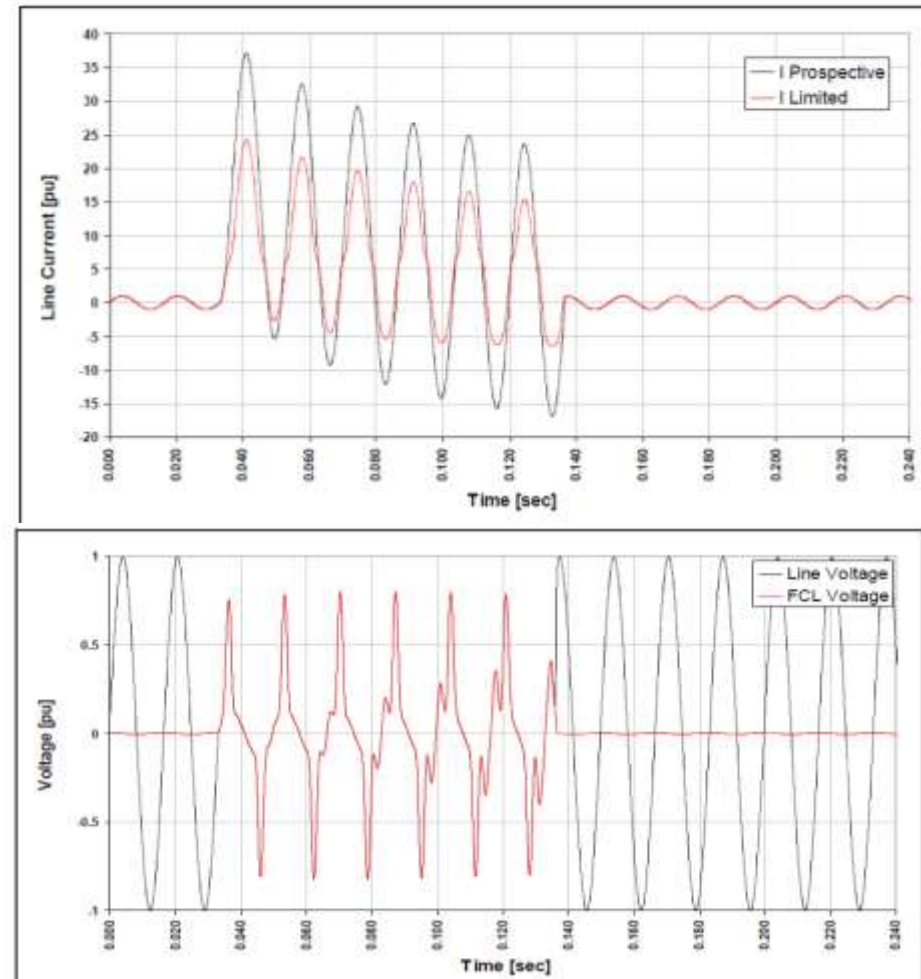
$$X_S = 0.0499 \text{ pu}$$

$$R_L = 0.9963 \text{ pu}$$

HTS resistive w/ resistive shunt type



Saturated iron core type



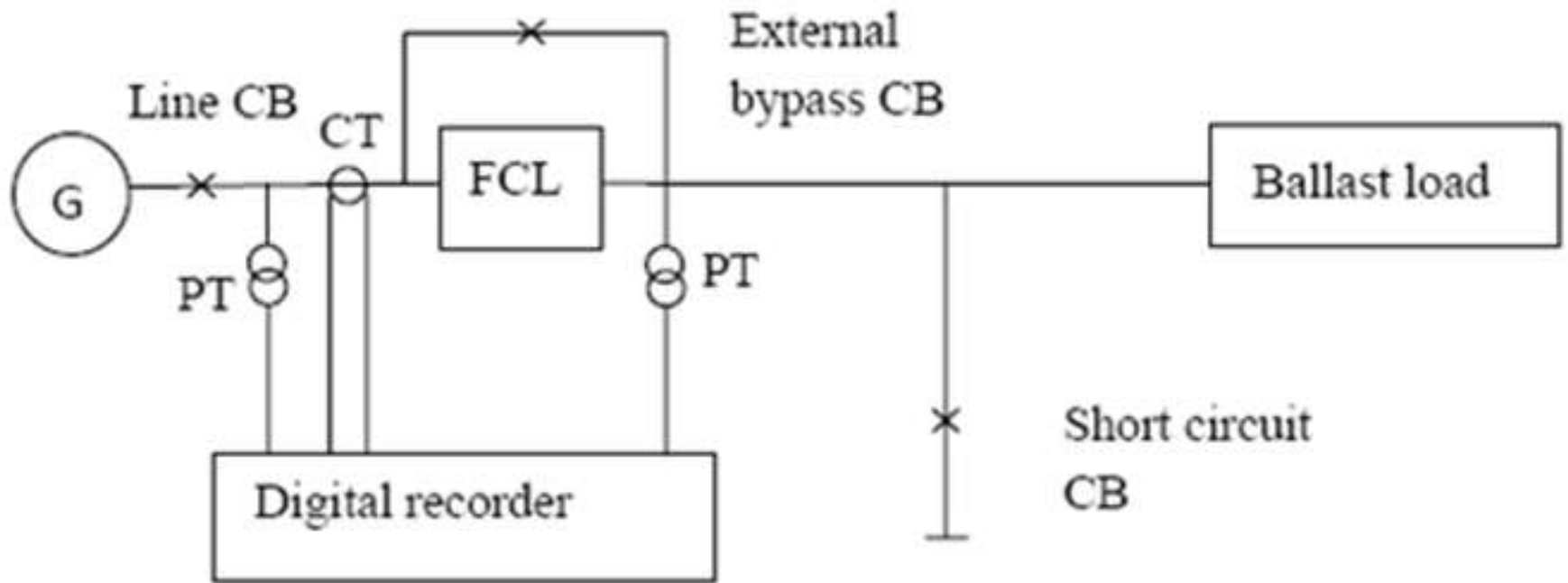


“Guide for Fault Current Limiter Testing”

- Design Tests
 - Dielectric tests
 - Power Frequency Voltage Withstand
 - Lightning Impulse Voltage
 - Switching Impulse Voltage
 - Chopped-Wave Voltage Impulse
 - Partial Discharge
 - Control Circuit Voltage Withstand
 - Current carrying and functional tests
 - Continuous Current (temp. rise, power loss, v drop)
 - Short-Time Withstand Current
 - Harmonic Distortion
 - Current Limiting (initiating, limited, action)
 - Recovery
 - Circuit Breaker Operation



Current Limiting Test Circuit





IEEE WG PC37.302



- Design Tests
 - Other tests
 - Protective Device
 - Electromagnetic Compatibility
 - Audible Sound
 - Vibration
 - Polarity
 - FCL Technology Specific Tests
- Production (routine) tests
- Field tests



Concluding Remarks



- Fault Current Limiters (FCL) are emerging Smart Grid technologies
- Where to find more information
 - CIGRE brochure 239 “*Fault Current Limiters in Electrical Medium and High Voltage Systems*”
 - CIGRE brochure 339 “*Guideline on the Impacts of Fault Current Limiting Devices on Protection Systems*”
 - EPRI “*Fault Management Guide Book*”
 - M. Noe and M. Steurer, “*High Temperature Superconductor Fault Current Limiters – Concepts, Applications, and Development Status*”, Supercond. Sci. Technol., No 20, 2007

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Supercond. Sci. Technol. 20 (2007) R15–R29

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TOPICAL REVIEW

High-temperature superconductor fault current limiters: concepts, applications, and development status

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